

PRODUCT DATA SHEET

WF-1082

Halogen-Free, Water-Wash, Wave Solder Flux

Introduction

WF-1082 is an alcohol-based, halogen-free, water-wash wave solder flux developed to comply with the latest J-STD-004, version B, and for soldering through-hole, bottom-side surface mount, and mixed-technology circuit boards. It performs well with both Pb-free and SnPb solders and processes and is compatible in both wave soldering and selective soldering applications. The residue left by **WF-1082** is highly water-soluble, allowing easy post-soldering removal in both batch and in-line cleaning processes.

Features

- Halogen-free
- Compatible with Pb-free and SnPb alloys
- Cleans easily in water
- Produces shiny solder joints
- Cleaning can be delayed up to 48 hours
- Compatible with Hot Air Solder Leveled (HASL), Immersion Silver, Electroless Nickel Immersion Gold (ENIG), and Organically Solder Preserved (OSP) copper surfaces
- Compatible with all tested solder masks
- Low-odor, polyglycol-free formulation
- Conforms to J-STD-004B flux type ORH0

Test	WF-1082	WF-1080-T
Color	Pale	Clear
Specific Gravity @ 25°C (77°F) @ 15°C (60°F)	0.920 0.925	0.815 0.822
Solids Content	14.46	N/A
Flash Point (°FTCC)	17°C (63°F)	17°C (63°F)
J-STD-004B Flux Type	ORH0	N/A

PRODUCT DATA SHEET

WF-1082

Halogen-Free, Water-Wash, Wave Solder Flux

TEST DATA

Copper Mirror

The J-STD-004B copper mirror test is performed per IPC-TM-650 method 2.3.32. To be classified as an "L" type flux, there should be no complete removal of the mirror surface. **WF-1082** exhibits >50% removal of the copper mirror and, therefore, is classified as a Type ORH0 flux.

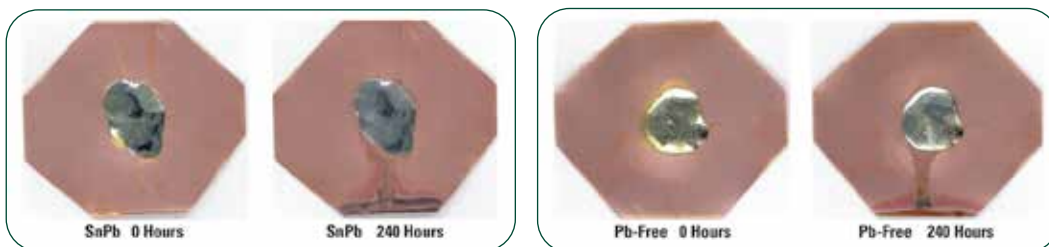


WF-1082

Standard Rosin

Copper Corrosion

Copper corrosion is tested per IPC-TM-650 method 2.6.15. This test gives an indication of any visible reactions that take place between the flux residue after soldering and copper surface finishes. In particular, green copper corrosion should not be seen. The copper corrosion test is not particularly useful in differentiating water-wash fluxes, since post-soldering residue must be removed after soldering.



SnPb 0 Hours

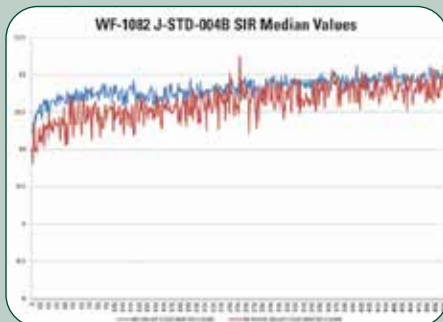
SnPb 240 Hours

Pb-Free 0 Hours

Pb-Free 240 Hours

Surface Insulation Resistance (SIR)

The Surface Insulation Resistance Test is performed per IPC-TM-650 method 2.6.3.7, using boards prepared per IPC-TM-650 method 2.6.3.3. All boards soldered with **WF-1082** pass the requirements of having exhibited no dendritic growth, no visible corrosion, and a minimum insulation resistance of 100 megohms (1×10^8). The values shown on the two graphs below show the number of Ohms times



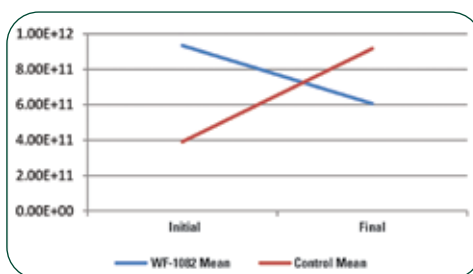
ten to the power of the vertical axis. The IPC-TM-650 SIR is a 7-day test and gives a general idea of the effect of the flux residue on the electrical properties of the surface of the circuit board.

J-STD-004B SIR Minimum Values No-Delay Clean		
	24+ Hours	All Data
Pattern Down*	9.47	9.47
Control	9.74	9.63

*Water-wash fluxes are only tested pattern down

Electromigration (ECM)

The electromigration test is performed to IPC-TM-650 method 2.6.14.1 with boards prepared using IPC-TM-650 method 2.6.3.3. The test conditions for this test are 496 hours at $65^\circ\text{C} \pm 2^\circ\text{C}$ and $88.5\% \pm 3.5\% \text{ RH}$. To pass this test, there should be no visible corrosion and no dendritic growth that decreases line spacing by more than 20%. In addition, the insulation resistance should not drop more than one order of magnitude after the first 96-hour stabilization period when a bias voltage is applied.



	Initial	Final
WF-1082	9.34E+11	6.06E+11
Control Mean	3.91E+11	9.17E+11
Result	Pass	

Contact our engineers today: askus@indium.com

Learn more: www.indium.com



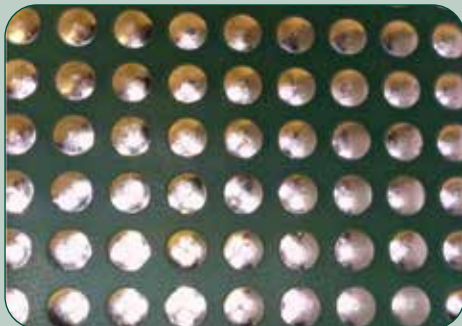
PRODUCT DATA SHEET

WF-1082

Halogen-Free, Water-Wash, Wave Solder Flux

PERFORMANCE AND PROCESS DATA

Hole Fill



Hole Fill Test Board

Indium Corporation uses several of its own tests, based on IPC workmanship standards, for determining hole fill. Depending on the design criteria for the flux, Indium Corporation uses holes of varying sizes and circuit board finishes. However, we always look for 100% hole fill, even though the IPC recognizes that a smaller degree of hole fill is acceptable for its workmanship standards. Testing is typically performed with both lead-free (Indium Corporation's Sn995 alloy) and tin-lead (63Sn/37Pb) solders.

Soldering Performance 0.062" Thick Test Board*

	Pb-Free	SnPb
100% PTH Fill Yield	99%+	99%+
*15–30mil diameter plated through-holes		

Soldering Performance 0.093" Thick Test Board*

	Pb-Free	SnPb
100% PTH Fill Yield	97%+	99%+
*22–45mil diameter plated through-holes		

Process Recommendations

- Can be applied by spray or foam
- When using with Immersion Silver and Immersion Tin, limit topside flux deposition to reduce staining

Foam Application

- Stone should be 1½ to 2 inches below flux surface
- Adjust air pressure to 1–3psi
- Adjust air knife pressure to 5psi to remove excess flux
- Use WF-1080-T flux thinner with the adjustment charts to maintain the flux density

62mil-thick Circuit Board Process Recommendations

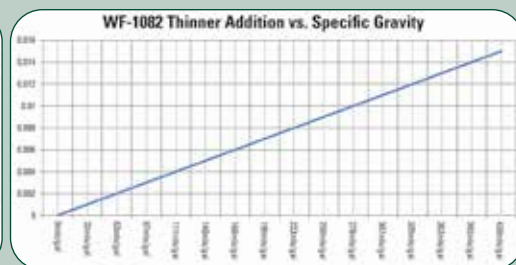
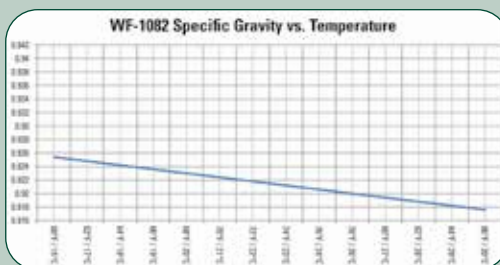
Flux Deposition Rate µg/in ² solids	Preheat Temp		Preheat Time (sec)	Alloy	Contact Time (sec)	Pot Temp (°C)
	Top (°C)	Bottom (°C)				
≤5,000	100–145	100–145	60–100	SnCu	3.5–5.5	265–275
≤5,000	80–125	90–125	50–75	SnPb	1.5–5	245–260

93mil-thick Circuit Board Process Recommendations

Flux Deposition Rate µg/in ² solids	Preheat Temp		Preheat Time (sec)	Alloy	Contact Time (sec)	Pot Temp (°C)
	Top (°C)	Bottom (°C)				
≤8,000	105–145	105–145	100–140	SnCu	5.5–7.5	265–275
≤8,000	105–130	105–130	60–100	SnPb	1.5–5	245–260

Instructions for Adding Thinner to WF-1082 When Foam Fluxing

- Determine the specific gravity and temperature of flux
- Find the flux temperature on the Specific Gravity vs. Temperature chart
- Subtract the correct specific gravity from the specific gravity of the flux
- Use the Thinner Addition vs. Specific Gravity chart to determine the mls/gal of thinner to add



Ionic Cleanliness Testing

Ionic cleanliness testing was developed at a time before no-clean fluxes became practical and popular. In those days, virtually ALL flux residues were removed from circuit boards as a means of ensuring both electrical integrity and a clean cosmetic appearance. The most common ionic testing specification used at the time was MIL-P-28809. To perform the test, an already-cleaned subject circuit board was immersed in an ion-free circulating alcohol/water bath for a set period of time. The electrical conductivity of the alcohol water solution was then measured to determine how much residual ionic material, as expressed as equivalent "µg NaCl/in²," was transferred from the circuit board to the bath. The more residual ionic material, the less effective the cleaning and the more danger existed for future electrical failure. The amount of ionic residue varies by flux type, cleaning method, and board complexity.

Ionic Cleanliness

Cleaning Performance	<5µg NaCl/in ²
Pass/Fail Limit	37.0µg NaCl/in ²
WF-1082 passes with very low ionic residue	

Contact our engineers today: askus@indium.com

Learn more: www.indium.com



PRODUCT DATA SHEET

WF-1082

Halogen-Free, Water-Wash, Wave Solder Flux

Water-Soluble Flux Residue Removal

Water-wash fluxes are designed to have their post-soldering residues removed from the circuit board. This is because, even though the residues may not be corrosive, they can be conductive, especially in humid environments. Some very aggressive water-wash fluxes must be removed immediately after soldering to prevent damage to the circuit board. However, washing boards soldered with **WF-1082** may be delayed for up to 48 hours. While the exact method of cleaning—batch or inline—is not important, what is important is ensuring that the equipment used is capable of complete flux removal.

Cleaning Recommendations

Water Temperature	20–50°C (68–122°F)
Cleaning Delay	≤48 hours

Technical Support

Indium Corporation's internationally experienced engineers provide in-depth technical assistance to our customers. Thoroughly knowledgeable in all facets of Material Science as it applies to the electronics and semiconductor sectors, Technical Support Engineers provide expert advice in solder preforms, wire, ribbon, and paste. Indium Corporation's Technical Support Engineers provide rapid response to all technical inquiries.

Safety Data Sheets

The SDS for this product is available by contacting askus@indium.com

Indium Corporation Complementary Products

- **Solder Paste:** Indium6.4R, Indium6.6HF
- **Cored Wire:** CW-305
- **Flux Pen:** FP-300

Indium Corporation has a long history of testing soldering product compatibility and has designed its solder pastes, wave fluxes, cored wires, and rework fluxes so that they are compatible with each other. Based on our experience, we have learned that Indium Corporation products that have been individually designed to meet the requirements of a certain specification, such as IPC J-STD-004B, when combined will yield test results meeting the same requirements, as typically determined by Surface Insulation Resistance (SIR) and Electromigration (ECM) testing. It is also possible that competitors' products and those that cross different specification revisions, such as an Indium Corporation solder paste tested to J-STD-004, a competitor wave flux tested to J-STD-004A, and an Indium Corporation cored wire tested to the requirements of J-STD-004B, will also be compatible when tested under one of the above versions, but it is not as certain. In these cases, where there is doubt, we prefer to run actual testing to confirm compatibility. Indium Corporation maintains a small library of these test results, which are made available to its customers. The safest way to ensure product compatibility is by using a complete line of Indium Corporation compatible products; however, if you have questions regarding the compatibility of a specific set of products, please contact Indium Corporation's Technical Support Department.

Additional Information

*J-STD-004B is the IPC Joint Industry Standard for classifying and testing soldering fluxes. It varies from the prior versions, J-STD-004 and J-STD-004A, in two very important ways. J-STD-004B uses a modified electromigration (ECM) test battery which is designed to better test the effects of the flux in high humidity conditions at normal operating temperatures and voltages. The environmental test is specifically designed to try to create dendritic growth and create failure in marginal flux formulas, unlike the prior version of J-STD-004 which used higher temperatures and voltages that did not grow dendrites as easily. Also, J-STD-004B halogen testing now reveals the total amount of halogen in a flux by first using an oxygen bomb to disassociate any halogen from the chemical compounds that they are bound to, and then collecting and quantifying them. Prior versions of J-STD-004 were unable to detect halogens that were present, but only disassociated at high temperatures (such as soldering temperature). As such, prior testing methods might give the user a false sense that no halogens are present in the flux when, in fact, they are. Indium Corporation strongly supports the enhanced features of J-STD-004B because it better serves the users' need for information.

This product data sheet is provided for general information only. It is not intended, and shall not be construed, to warrant or guarantee the performance of the products described which are sold subject exclusively to written warranties and limitations thereon included in product packaging and invoices. All Indium Corporation's products and solutions are designed to be commercially available unless specifically stated otherwise.

All of Indium Corporation's solder paste and preform manufacturing facilities are IATF 16949:2016 certified. Indium Corporation is an ISO 9001:2015 registered company.

Contact our engineers: askus@indium.com

Learn more: www.indium.com

ASIA +65 6268 8678 • CHINA +86 (0) 512 628 34900 • EUROPE +44 (0) 1908 580400 • USA +1 315 853 4900



©2022 Indium Corporation